# Limited-Data CT for Underwater Pipeline Inspection

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#### **DTU** Compute

Department of Applied Mathematics and Computer Science

 $f(x+\Delta x) = \sum_{i=1}^{\infty} \frac{(\Delta x)^{i}}{i!} f^{(i)}$ 

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Alternative to ultrasound: use X-ray scanning to compute cross-sectional images of oil pipes lying on the seabed, to detect defects, cracks, etc. in the pipe.



Illustration courtesy of FORCE Technology.



https://forcetechnology.com/da/innovation/afsluttede-projekter/subsea-inspektion-konstruktion-levetid-reparation-planlaegning

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# **Comparing Geometries**

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### Limitations in the scanner device

Data: Narrow high intensity X-Ray beam  $\rightarrow$  available from a limited view.

Goal: Design set-up to capture as much detail of the pipe as possible.



Full illumination Not possible Centered Possible set-up



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#### Continuous formulation, limited data

The measured projections g for the object f are described by

$$g(\theta, s) = (\mathcal{R}^{\ell} f)(\theta, s) + \mathsf{noise}$$

where  $(\mathcal{R}^{\ell}f)(\theta, s) = (\mathcal{R}f)(\theta, s)$  for those pairs  $(\theta, s)$  corresponding to the  $\ell$  imited illumination, and  $\mathcal{R}$  is the Radon transform.

#### **Corresponding algebraic model**

The measured data  $\boldsymbol{b}$  for a discretized object  $\boldsymbol{x}$  is described by

$$oldsymbol{b} = oldsymbol{A}^\ell oldsymbol{x} + oldsymbol{e}, \qquad oldsymbol{b} \in \mathbb{R}^m, \qquad oldsymbol{x} \in \mathbb{R}^n, \qquad oldsymbol{A}^\ell \in \mathbb{R}^{m imes n},$$

where  $e \in \mathbb{R}^m$  with  $e_i \sim N(0, \sigma^2)$  and  $A^{\ell}$  is the discretion of  $\mathcal{R}^{\ell}$ .

# **Full and Two Different Limited Illuminations**











Source location



Source location



Source location

# **Characterising What We Can Measure - Centered Beam**

**Microlocal analysis:** a singularity at position  $\chi$  with direction  $\xi$  is visible if and only if data from the line through  $\chi$  perpendicular to  $\xi$  is present.



Measured data from one view/projection.

 $\bigcirc$ 

Visible from one view/projection.



Visible from all views/projections.

# **Characterising What We Can Measure - Off-Center Beam**

**Microlocal analysis:** a singularity at position  $\chi$  with direction  $\xi$  is visible if and only if data from the line through  $\chi$  perpendicular to  $\xi$  is present.



Measured data from one view/projection.



Visible from one view/projection.



Visible from all views/projections.

We need a robust algorithm that can utilize all information in the data.

Use the algebraic system

 $oldsymbol{b} = oldsymbol{A}^\ell \, oldsymbol{x} + \mathbf{e}, \qquad oldsymbol{b} \in \mathbb{R}^m, \qquad oldsymbol{x} \in \mathbb{R}^n, \qquad oldsymbol{A}^\ell \in \mathbb{R}^{m imes n}.$ 

and compute a sparse representation of the solution x in a "basis" that is well suited for the problem.

If we can represent x with few non-zero basis functions, we have fewer unknowns to determine  $\rightarrow$  same data, fewer unknowns, "easier" problem.

# Representing pipe in a sparse "basis"



#### Frame decomposition Given an object, x, we decompose it into building blocks

$$oldsymbol{x} = \sum_{\mu} c_{\mu} oldsymbol{arphi}_{\mu},$$

where  $\varphi_{\mu}$  are the building blocks and  $c_{\mu} = \langle x, \varphi_{\mu} \rangle$ . are coefficients. \*If the object is fully represented by few building blocks, we have a sparse representation.

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### Example:



# Representing pipe in a sparse "basis"



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### Example:



### Why is this useful?

# Why enforce sparsity of frame coefficients?



#### Noise/artefact reduction:





# Why enforce sparsity of frame coefficients?



#### Noise/artefact reduction:

0  $+ c_{3}$  $+ c_{2}$  $c_1$ Decompose  $+c_4$  $+ c_{5}$ Too strong prior!

# Why enforce sparsity of frame coefficients?



#### Noise/artefact reduction:

0  $+ c_{3}$  $+ c_2$  $c_1$ Decompose  $+c_4$  $+ c_{5}$ Too strong prior! Not all images are fully represented by the decompositon.

### Shearlets: A tight frame

Tight frames,  $\mathbf{\Phi} = ig\{ arphi_\mu ig\}$ , generalises ONB, i.e., for all images x we have

$$oldsymbol{x} = \sum_{\mu} \langle oldsymbol{x}, oldsymbol{arphi}_{\mu} 
angle oldsymbol{arphi}_{\mu}.$$

#### Examples of 2D Shearlets:



Shearlets yield a sparse representation of defects, contours, etc.



# **Shearlet-based optimization problem**



Recall discrete model of scanning process:  $m{b} = m{A}^\ell \, m{x} + f{e}.$ 

#### Reconstruction with a weighted shearlet-based sparsity penalty

Optimization problem:

$$\arg\min_{\mathbf{x} \ge \mathbf{0}} \frac{1}{2} \| \mathbf{A}^{\ell} \mathbf{x} - \mathbf{b} \|_{2}^{2} + \alpha \| \mathbf{W} \mathbf{c} \|_{1},$$
  
s.t.  $\mathbf{c} = \mathbf{\Phi} \mathbf{x}$ 

with  $\alpha > 0$  regularization parameter,  $\mathbf{W} = \text{diag}(w_i) \in \mathbb{R}^{p \times p}$  with weights  $w_i > 0$ ,  $\mathbf{\Phi} \in \mathbb{R}^{p \times n}$  is the shearlet analysis transform and  $c_{\mu} = \langle \boldsymbol{x}, \boldsymbol{\varphi}_{\mu} \rangle$  are coefficients.

Shearlet transform contains the basis functions:  $\mathbf{\Phi}^T = \begin{bmatrix} \varphi_1, & \dots, & \varphi_p \end{bmatrix}$ .



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Shearlet transform contains the basis functions:  $\Phi^T = [\varphi_1, \dots, \varphi_p]$ . Weighted sparsity penalty on shearlet coefficients

# **Final algorithm**



Recall optimization problem:

$$\begin{split} &\arg\min_{\mathbf{x}\geq\mathbf{0}}\frac{1}{2}\|\boldsymbol{A}^{\ell}\mathbf{x}-\mathbf{b}\|_{2}^{2}+\alpha\|\mathbf{W}\mathbf{c}\|_{1},\\ &\text{s.t. }\mathbf{c}=\boldsymbol{\Phi}\boldsymbol{x} \end{split}$$

#### **ADMM-based algorithm**

We solve it using the ADMM method [Boyd et. al. 2011]. Auxiliary variable  $\mathbf{c}=\Phi\mathbf{x}.$  Iterative updates:

$$\begin{split} \mathbf{x}^{k+1} &:= \min_{\mathbf{x} \ge \mathbf{0}} \quad \frac{1}{2} \| \mathbf{A}^{\ell} \, \mathbf{x} - \mathbf{b} \|_{2}^{2} + \frac{\rho}{2} \| \mathbf{\Phi} \, \mathbf{x} - \mathbf{c}^{k} + \mathbf{u}^{k} \|_{2}^{2}, \\ \mathbf{c}^{k+1} &:= \min_{\mathbf{c}} \quad \alpha \| \mathbf{W} \, \mathbf{c} \|_{1} + \frac{\rho}{2} \| \mathbf{\Phi} \, \mathbf{x}^{k+1} - \mathbf{c} + \mathbf{u}^{k} \|_{2}^{2}, \\ \mathbf{u}^{k+1} &:= \mathbf{u}^{k} + \mathbf{\Phi} \, \mathbf{x}^{k+1} - \mathbf{c}^{k+1}, \end{split}$$

where  ${\bf u}$  are the scaled Lagrange multipliers and  $\rho>0$  the penalty parameter.

The updates are calculated using:  $\mathbf{x}^{k+1}$ : CGLS + non-negativity projection.  $\mathbf{c}^{k+1}$ : Element-wise soft thresholding.



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# Synthetic and measured data from both geometries





# **Reconstructions from Real Data – Both Geometries**

**Centered beam:** there are many artifacts.



Off-center beam: singularities are easy to detect; artifacts are reduced.



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### **Reconstructions from Real Data – Zoom**

Off-center beam: singularities are easy to detect; artifacts are reduced.

Prev. alg.



Our alg.



### **Reconstructions from Real Data – Zoom**

Off-center beam: singularities are easy to detect; artifacts are reduced.

 $\arg\min_{\mathbf{x} \ge \mathbf{0}} \|\boldsymbol{A}\boldsymbol{x} - \boldsymbol{b}\|_2^2 + \lambda \|\nabla \boldsymbol{x}\|_{2,1}$ 



Our alg.



### **Centered Versus Off-Center Beam**

	Centered beam	Off-center beam
Pros	Good reconstruction in the	Captures singularities out-
	center domain.	side the center domain.
Cons	Terrible reconstruction outside	Less good reconstruction in
	the center domain.	the center domain.
Comments	Requires less projections be-	Requires more projections to
	cause the center domain is well	give good reconstruction ev-
	covered by rays.	erywhere.
		Better suited for this applica-
		tion.

### Conclusions

- For technical reasons the X-ray beam cannot cover the whole pipe.
- An off-centered beam can give a satisfactory reconstruction.
- A weighted shearlets-based sparsity penalty gives better reconstructions especially with few projections.
- It is important to include weights in the sparsity penalty.

Future work:

- Optimize the algorithm for performance and robustness.
- Design heuristics for choosing the weights and the reg. parameter.
- Derive more theory for the continuous model with limited data.
- Quantify the uncertainties in the model and the solution.

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#### Introduction Formulation of problem



$$oldsymbol{b} = \mathbf{A}(oldsymbol{ heta}) \, \mathbf{x} + \mathbf{e}, \quad oldsymbol{ heta} \sim \pi_{oldsymbol{ heta}}(\cdot), \, \mathbf{e} \sim \pi_{\mathbf{e}}(\cdot).$$

#### Measured / fixed:

 $m{b} \in \mathbb{R}^m$ : measured noisy sinogram.  $\mathbf{A} \in \mathbb{R}^{m imes n}$ : discretized Radon transform.

#### Known but with uncertainty:

 $oldsymbol{ heta} \in \mathbb{R}^q$ : view angles.  $\mathbf{e} \in \mathbb{R}^m$ : measurement noise.

#### Unknown:

 $\mathbf{x} \in \mathbb{R}^n$ : attenuation coefficients.



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(1)

#### Introduction Formulation of problem

#### **Uncertain view angle CT**

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Actual data comes from  $b := \mathbf{A}(\overline{\boldsymbol{\theta}}) \mathbf{x} + \mathbf{e}^{\text{noise}}$ .



(1)

#### Introduction Formulation of problem



(1)

**Uncertain view angle CT** 

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#### **Goal:** Reconstruct x from b with uncertainty in $\theta$ and e!

### **Applications:**

Inaccuracies in rotation, patient motion etc.

#### Introduction Early results





#### Introduction Early results 2





#### Introduction Ongoing Research - Uncertain View Angles

- Large scale problems  $(2D \rightarrow 3D)$
- Apply to pipe scanner (with shearlet regularizer)

# Thank you!

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